

22. Dosimetric E-Field Probe Calibration (EX3DV3,S/N: 3507)

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Client **UL Japan (PTT)**Certificate No: **EX3-3507_Feb10****CALIBRATION CERTIFICATE**Object **EX3DV3 - SN:3507**Calibration procedure(s) **QA CAL-01.v6, QA CAL-14.v3, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes**Calibration date: **February 19, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495087	1-Apr-09 (No. 217-01030)	Apr-10
Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 660	29-Sep-09 (No. DAE4-660_Sep09)	Sep-10

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct10

Calibrated by:	Name Katja Pokovic	Function Technical Manager	Signature
Approved by:	Name Niels Kuster	Function Quality Manager	

Issued: February 19, 2010

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Certificate No: EX3-3507_Feb10

Page 1 of 11

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Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

EX3DV3 SN:3507

February 19, 2010

Probe EX3DV3

SN:3507

Manufactured:	December 15, 2003
Last calibrated:	February 12, 2009
Recalibrated:	February 19, 2010

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

EX3DV3 SN:3507

February 19, 2010

DASY - Parameters of Probe: EX3DV3 SN:3507**Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.68	0.73	0.69	± 10.1%
DCP (mV) ^B	94.7	90.2	92.4	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			Z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E₂-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV3 SN:3507

February 19, 2010

DASY - Parameters of Probe: EX3DV3 SN:3507**Calibration Parameter Determined in Head Tissue Simulating Media**

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	41.5 ± 5%	0.80 ± 5%	10.59	10.59	10.59	0.41	0.77 ± 11.0%
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	10.25	10.25	10.25	0.60	0.63 ± 11.0%
1640	± 50 / ± 100	40.3 ± 5%	1.29 ± 5%	9.45	9.45	9.45	0.59	0.62 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	9.16	9.16	9.16	0.83	0.50 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	8.90	8.90	8.90	0.98	0.46 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	8.73	8.73	8.73	0.83	0.47 ± 11.0%
2000	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	8.66	8.66	8.66	0.66	0.54 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	8.01	8.01	8.01	0.27	0.85 ± 11.0%
5200	± 50 / ± 100	36.0 ± 5%	4.66 ± 5%	5.14	5.14	5.14	0.30	1.90 ± 13.1%
5300	± 50 / ± 100	35.9 ± 5%	4.76 ± 5%	4.76	4.76	4.76	0.35	1.90 ± 13.1%
5500	± 50 / ± 100	35.6 ± 5%	4.96 ± 5%	4.36	4.36	4.36	0.40	1.90 ± 13.1%
5600	± 50 / ± 100	35.5 ± 5%	5.07 ± 5%	4.12	4.12	4.12	0.50	1.90 ± 13.1%
5800	± 50 / ± 100	35.3 ± 5%	5.27 ± 5%	4.10	4.10	4.10	0.50	1.90 ± 13.1%

^C The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV3 SN:3507

February 19, 2010

DASY - Parameters of Probe: EX3DV3 SN:3507**Calibration Parameter Determined in Body Tissue Simulating Media**

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	10.29	10.29	10.29	0.45	0.77 ± 11.0%
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	10.13	10.13	10.13	0.58	0.68 ± 11.0%
1640	± 50 / ± 100	53.8 ± 5%	1.40 ± 5%	9.49	9.49	9.49	0.99	0.47 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	8.79	8.79	8.79	0.59	0.60 ± 11.0%
1810	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	8.66	8.66	8.66	0.49	0.70 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	8.47	8.47	8.47	0.28	1.00 ± 11.0%
2000	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	8.61	8.61	8.61	0.39	0.80 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	8.11	8.11	8.11	0.28	0.98 ± 11.0%
5200	± 50 / ± 100	49.0 ± 5%	5.30 ± 5%	4.41	4.41	4.41	0.55	1.95 ± 13.1%
5300	± 50 / ± 100	48.5 ± 5%	5.42 ± 5%	4.22	4.22	4.22	0.60	1.95 ± 13.1%
5500	± 50 / ± 100	48.6 ± 5%	5.65 ± 5%	3.78	3.78	3.78	0.60	1.95 ± 13.1%
5800	± 50 / ± 100	48.5 ± 5%	5.77 ± 5%	3.59	3.59	3.59	0.63	1.95 ± 13.1%
5800	± 50 / ± 100	48.2 ± 5%	6.00 ± 5%	3.59	3.59	3.59	0.65	1.95 ± 13.1%

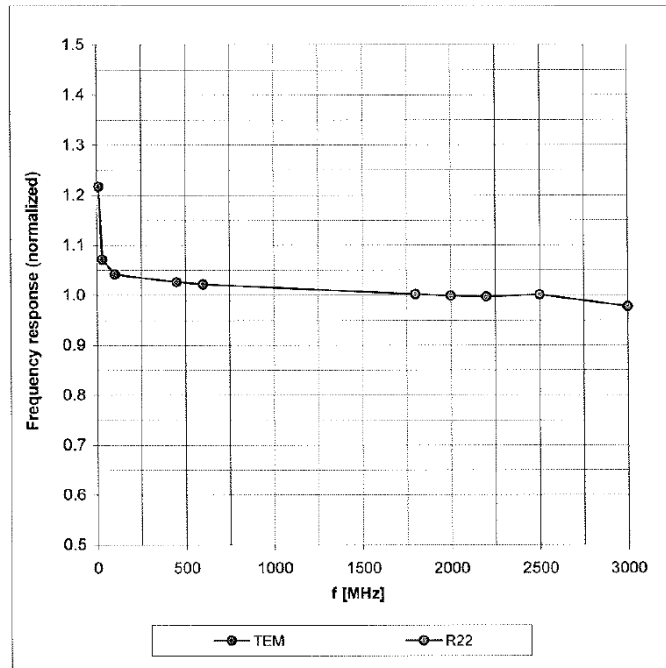
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV3 SN:3507

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Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

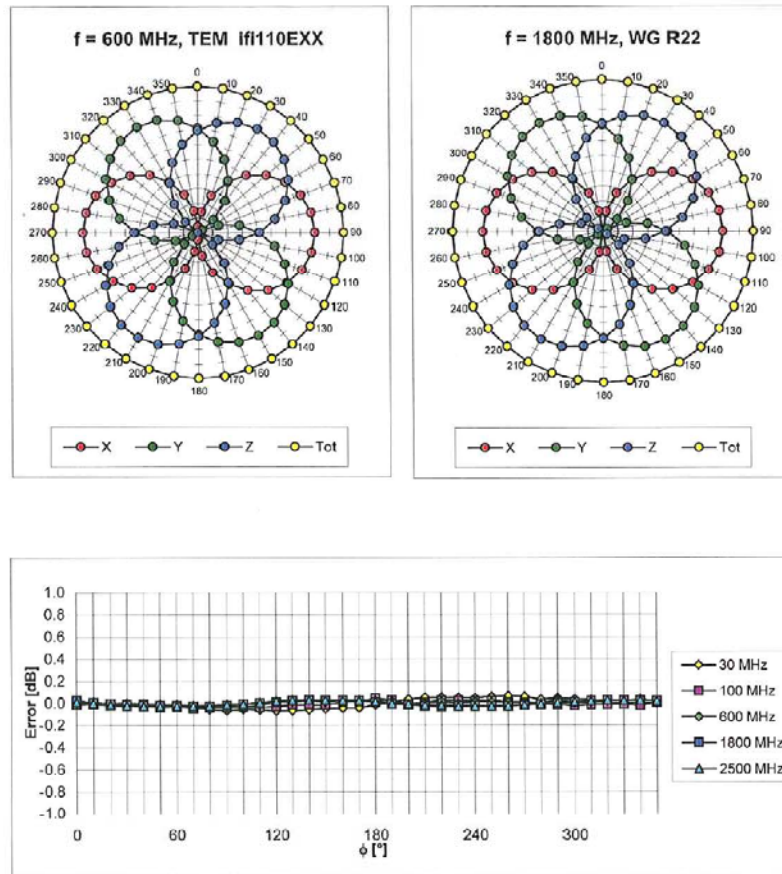


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV3 SN:3507

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Receiving Pattern (ϕ), $\theta = 0^\circ$

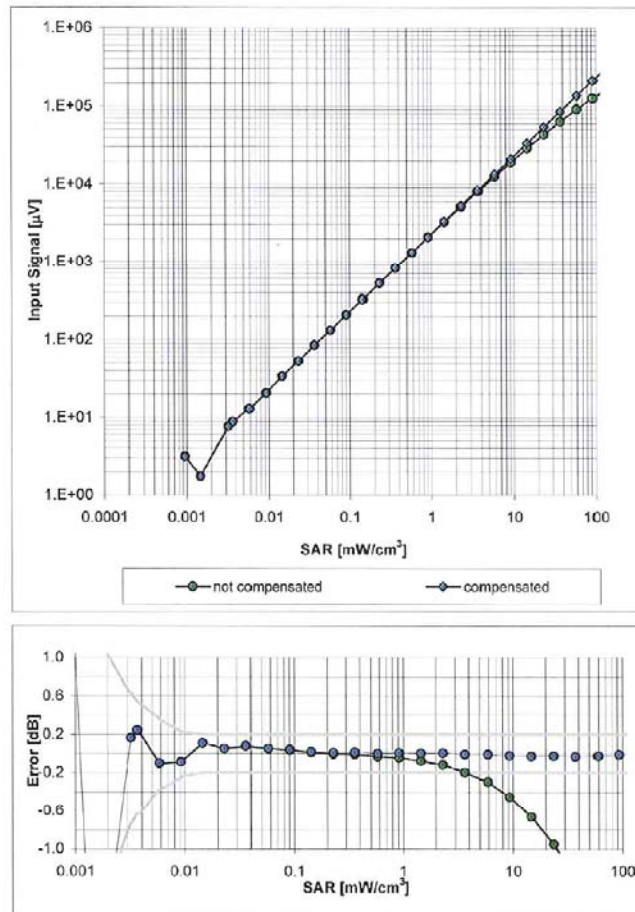


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

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Dynamic Range f(SAR_{head}) (Waveguide R22, f = 1800 MHz)

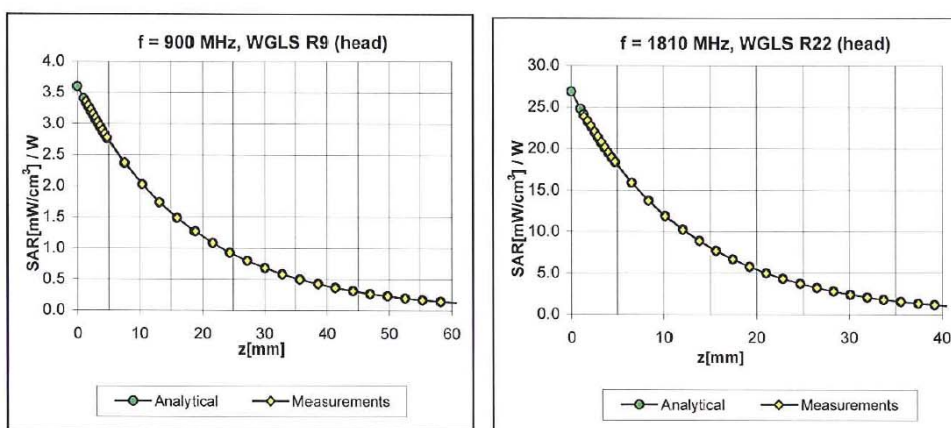


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

EX3DV3 SN:3507

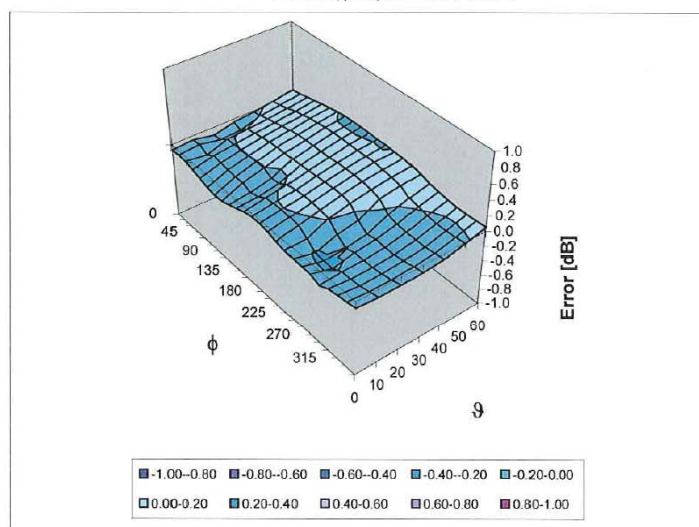
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Conversion Factor Assessment



Deviation from Isotropy in HSL

Error (ϕ , θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

EX3DV3 SN:3507

February 19, 2010

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm

23. Dosimetric E-Field Probe Calibration (ET3DV6,S/N: 1740)

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Client **PTT**

Certificate No: ET3-1740_Dec10

CALIBRATION CERTIFICATEObject **ET3DV6 - SN:1740**
 Calibration procedure(s) **QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2**
Calibration procedure for dosimetric E-field probes
Calibration date: **December 14, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator	SN: S5054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20 dB Attenuator	SN: S5086 (20b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30 dB Attenuator	SN: S5129 (30b)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 660	20-Apr-10 (No. DAE4-660_Apr10)	Apr-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

Calibrated by:	Name Jeton Kastrati	Function Laboratory Technician	Signature
Approved by:	Name Katja Pokovic	Function Technical Manager	Signature

Issued: December 14, 2010

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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1740

December 14, 2011

Probe ET3DV6

SN:1740

Manufactured:	September 27, 2002
Last calibrated:	December 14, 2009
Recalibrated:	December 14, 2010

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

ET3DV6 SN:1740

December 14, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1740**Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	1.62	1.52	1.54	± 10.1%
DCP (mV) ^B	98.8	99.2	99.2	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	99.5	± 2.4 %
			Y	0.00	0.00	1.00	92.9	
			Z	0.00	0.00	1.00	94.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

ET3DV6 SN:1740

December 14, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1740**Calibration Parameter Determined in Head Tissue Simulating Media**

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	41.5 ± 5%	0.90 ± 5%	6.39	6.39	6.39	0.47	2.10 ± 11.0%
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	6.31	6.31	6.31	0.36	2.44 ± 11.0%
1640	± 50 / ± 100	40.3 ± 5%	1.29 ± 5%	5.62	5.62	5.62	0.43	3.07 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	5.44	5.44	5.44	0.49	2.70 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.32	5.32	5.32	0.49	2.68 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.20	5.20	5.20	0.60	2.35 ± 11.0%
1950	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.01	5.01	5.01	0.67	2.20 ± 11.0%
2000	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.12	5.12	5.12	0.74	2.09 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.68	4.68	4.68	0.99	1.95 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

ET3DV6 SN:1740

December 14, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1740**Calibration Parameter Determined in Body Tissue Simulating Media**

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	6.29	6.29	6.29	0.34	2.58 ± 11.0%
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	6.15	6.15	6.15	0.31	2.89 ± 11.0%
1640	± 50 / ± 100	53.8 ± 5%	1.40 ± 5%	5.07	5.07	5.07	0.51	3.35 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	4.73	4.73	4.73	0.57	3.19 ± 11.0%
1810	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.86	4.66	4.66	0.63	2.98 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.47	4.47	4.47	0.81	2.48 ± 11.0%
1950	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.58	4.58	4.58	0.88	2.30 ± 11.0%
2000	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.53	4.53	4.53	0.95	2.30 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	3.96	3.96	3.96	0.90	1.90 ± 11.0%

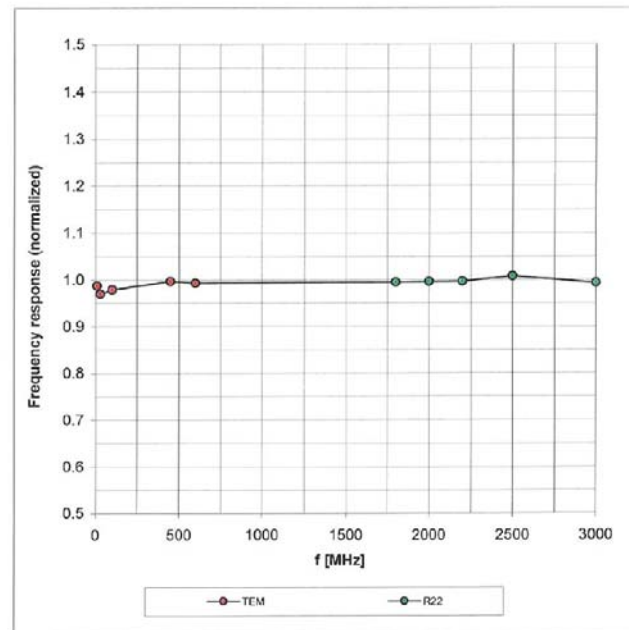
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

ET3DV6 SN:1740

December 14, 2010

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

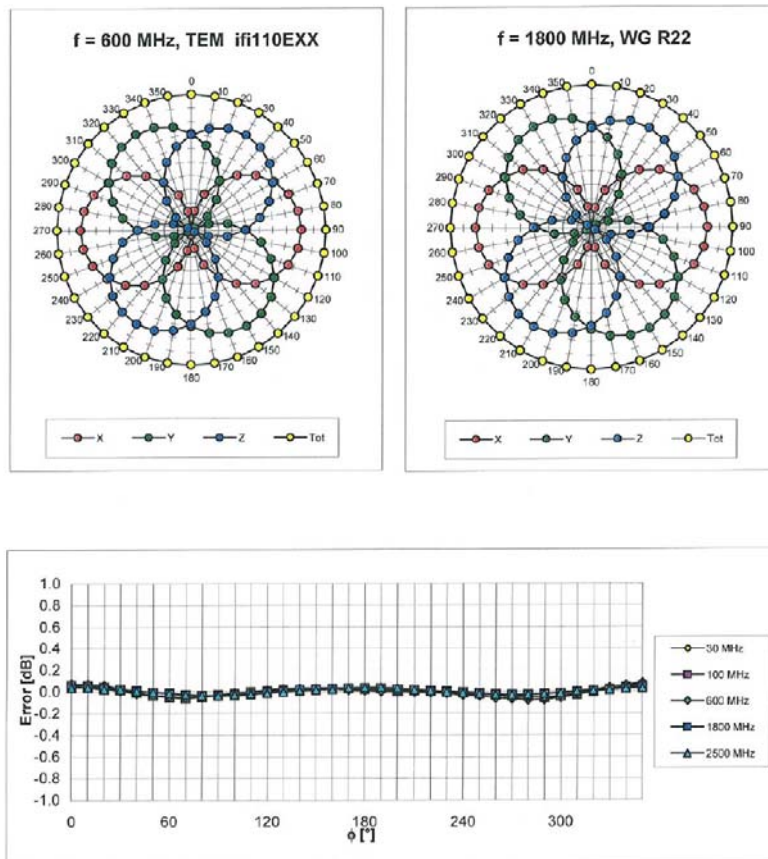


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

ET3DV6 SN:1740

December 14, 2010

Receiving Pattern (ϕ), $\theta = 0^\circ$



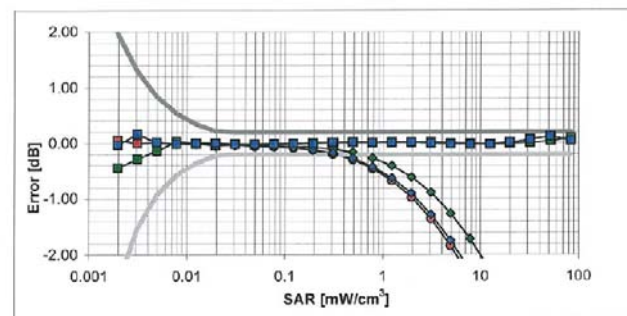
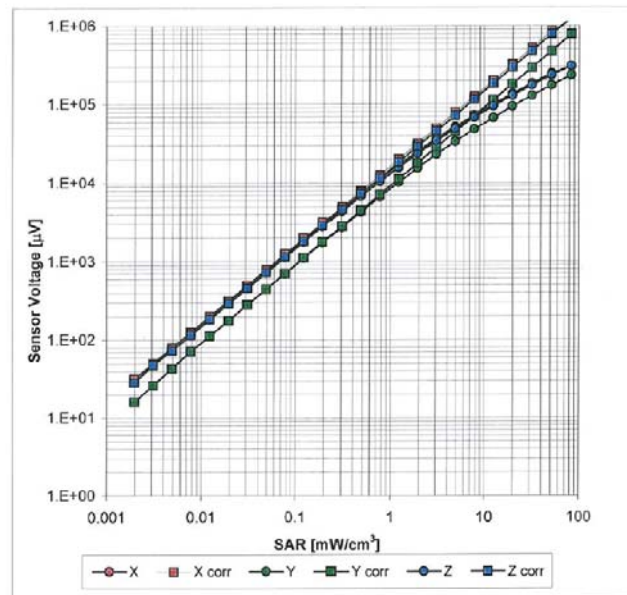
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

ET3DV6 SN:1740

December 14, 2010

Dynamic Range $f(\text{SAR}_{\text{head}})$

(TEM cell, $f = 900 \text{ MHz}$)

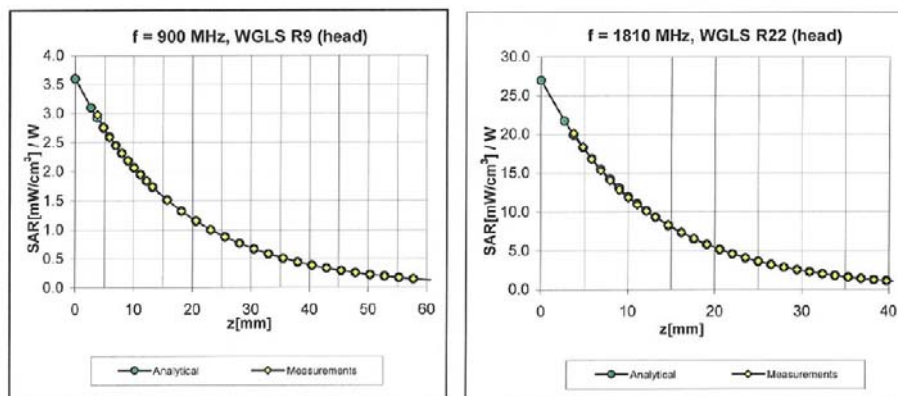


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ET3DV6 SN:1740

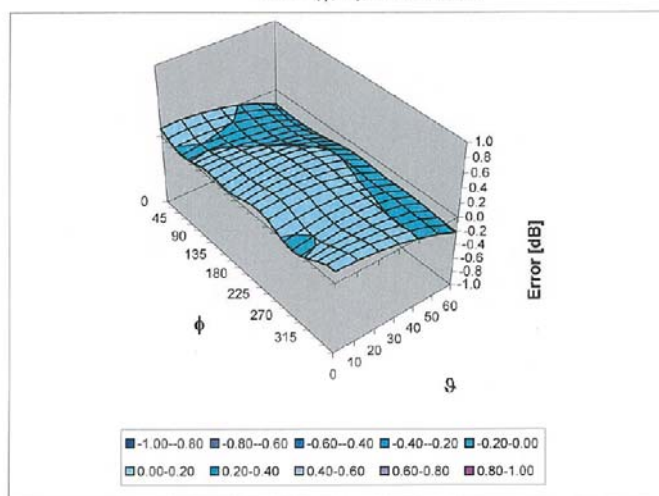
December 14, 2010

Conversion Factor Assessment



Deviation from Isotropy in HSL

Error (ϕ , θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

ET3DV6 SN:1740

December 14, 2010

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	enabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	3.7 mm

24. References

- [1]ANSI, ANSI/IEEE C95.1-1992: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz, The Institute of Electrical and Electronics Engineers, Inc., New York, NY 10017, 1992.
- [2] Katja Pokovic, Thomas Schmid, and Niels Kuster, “Robust setup for precise calibration of E-field probes in tissue simulating liquids at mobile communications frequencies”, in ICECOM ‘97, Dubrovnik, October 15-17, 1997, pp. 120-124.
- [3] Katja Pokovic, Thomas Schmid, and Niels Kuster, “E- field probe with improved isotropy in brain simulating liquids”, in Proceedings of the ELMAR, Zadar, Croatia, 23-25 June, 1996, pp.172-175.
- [4] W. Gander, Computermathematik, Birkhaeuser, Basel, 1992.
- [5] W. H. Press, S. A. Teukolsky, W. T. Vetterling, and B. P. Flannery, Numerical Recipes in C, The Art of Scientific Computing, Second Edition, Cambridge University Press, 1992.
- [6]SPEAG uncertainty document (AN 15-7/AN19-17) for DASY 5 System from SPEAG (Shimid & Partner Engineering AG).